

256-Channel, 16-Bit, Charge-to-Digital AFE on Flex

Data Sheet ADAS1256

FEATURES

256-channel, charge-to-digital conversion on a single chip

16-bit resolution with no missing codes

Simultaneous sampling

User adjustable full-scale range up to 32 pC

Down to 22 µs line time

Ultralow noise: 560 e- at 2 pC range

INL \pm 2.5 LSB or 57.5 ppm, ADC included

Multiple functional power modes: 1 mW/channel to

3 mW/channel

Multiple power-down and sleep modes:

down to 0.005 mW/channel

Measurement of electron or hole collected charge

Tested and delivered on high density system on flex (SOF)

LVDS/CMOS self-clocked serial interface

SPI daisy-chain configuration registers

On-board AFE timing sequencer

On-board temperature sensor and reference buffer

APPLICATIONS

Digital X-ray panel

Photodiode sensors array

CT scanner

High channel count, data acquisition systems (current or voltage input)

GENERAL DESCRIPTION

The ADAS1256 is a 256-channel, 16-bit, digital X-ray analog front end (AFE) that integrates the complete charge-to-digital conversion signal chain on a single chip. It enables a wide range of digital X-ray modalities, including portable radiology and mammography as well as high speed fluoroscopy and cardiac imaging. The ADAS1256 is delivered on a high density systemon-flex (SOF) package that can be directly mounted on a digital X-ray panel.

All converted channel results are output on a single LVDS self-clocked serial interface that significantly reduces external hardware.

An SPI-compatible serial interface allows configuration of the AFE, using the SDI input. The SDO output allows the user to daisy-chain several AFEs on a single 3-wire bus.

An integrated AFE timing sequencer controls the sampling activity of the analog front end (AFE). The sequencer is programmed via the SPI port and is timed by a single clock, ACLK.

FUNCTIONAL BLOCK DIAGRAM

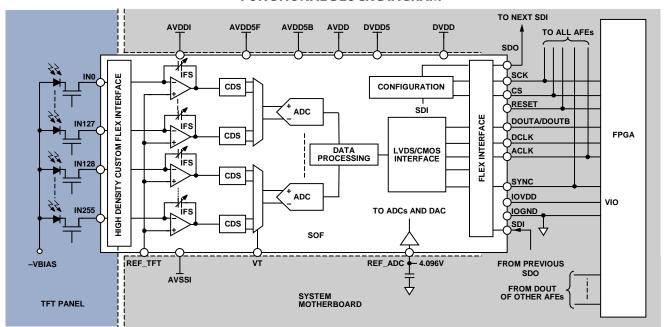


Figure 1.

ADAS1256 Data Sheet

NOTES